



ISO7230A ISO7231A

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## One Megabit per Second Triple Digital Isolators

Check for Samples: ISO7230A, ISO7231A

#### **FEATURES**

- 1Mbps Signaling Rate
  - Low Channel-to-Channel Output Skew;
     2ns Maximum (5V-Operation)
  - Low Pulse-Width Distortion (PWD);
     10ns Maximum (5V-Operation)
- Typical 25-Year Life at Rated Working Voltage (See Application note SLLA197 and Figure 10)
- 4000V<sub>peak</sub> Isolation, 560V<sub>peak</sub> V<sub>IORM</sub>
  - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2),
     IE 61010-1 and CSA Approved, IEC 60950-1
- 4kV ESD Protection
- Operate With 3.3V or 5V Supplies

- High Electromagnetic Immunity (See Application note SLLA181)
- –40°C to 125°C Operating Range

#### **APPLICATIONS**

- · Industrial Fieldbus
- Computer Peripheral Interface
- Servo Control Interface
- Data Acquisition

#### **DESCRIPTION**

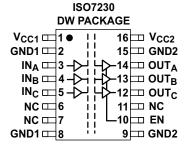
See the Product Notification section. The ISO7230A and ISO7231A are triple-channel digital isolators each with multiple channel configurations and output-enable functions. These devices have logic input and output buffers separated by Tl's silicon dioxide (SiO<sub>2</sub>) isolation barrier. Used in conjunction with isolated power supplies, these devices block high voltage, isolate grounds, and prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

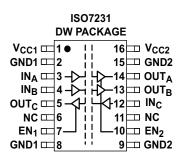
The ISO7230 triple-channel device has all three channels in the same direction while the ISO7231 has two channels in one direction and one channel in opposition. These devices have an active-high output enable that when driven to a low level, places the output in a high-impedance state.

The ISO7230A and ISO7231A have TTL input thresholds and a noise-filter at the input that prevents transient pulses of up to 2ns in duration from being passed to the output of the device.

In each device a periodic update pulse is sent across the isolation barrier to ensure the proper dc level of the output. If this dc-refresh pulse is not received, the input is assumed to be unpowered or not being actively driven, and the failsafe circuit drives the output to a logic high state. (Contact TI for a logic low failsafe option).

These devices require two supply voltages of 3.3V, 5V, or any combination. All inputs are 5V tolerant when supplied from a 3.3V supply and all outputs are 4mA CMOS. These devices are characterized for operation over the ambient temperature range of –40°C to 125°C.







Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### **FUNCTION DIAGRAM**

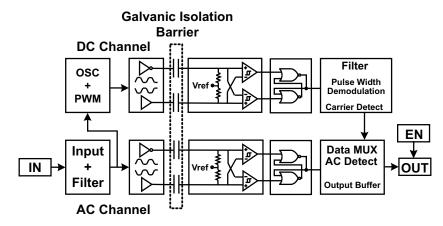


Table 1. Device Function Table ISO723x (1)

| INPUT V <sub>CC</sub> | OUTPUT V <sub>CC</sub> | INPUT<br>(IN) | OUTPUT ENABLE<br>(EN) | OUTPUT<br>(OUT) |
|-----------------------|------------------------|---------------|-----------------------|-----------------|
|                       |                        | Н             | H or Open             | Н               |
| DU                    | DU                     | L             | H or Open             | L               |
| PU                    | PU                     | X             | L                     | Z               |
|                       |                        | Open          | H or Open             | Н               |
| PD                    | PU                     | Х             | H or Open             | Н               |
| PD                    | PU                     | Х             | L                     | Z               |

(1) PU = Powered Up; PD = Powered Down; X = Irrelevant; H = High Level; L = Low Level

#### **AVAILABLE OPTIONS**

| PRODUCT       | SIGNALING<br>RATE | INPUT<br>THRESHOLD               | CHANNEL CONFIGURATION | MARKED<br>AS | ORDERING<br>NUMBER <sup>(1)</sup>    |
|---------------|-------------------|----------------------------------|-----------------------|--------------|--------------------------------------|
| ISO7230ADW    | 1 Mbps            | ~1.5V (TTL)<br>(CMOS compatible) | 3/0                   | ISO7230A     | ISO7230ADW (rail) ISO7230ADWR (reel) |
| 1007004 A DVA | 4 Mb a -          | ~1.5 V (TTL)                     | 0/4                   | 10070044     | ISO7231ADW (rail)                    |
| ISO7231ADW    | 1 Mbps            | (CMOS compatible)                | 2/1                   | ISO7231A     | ISO7231ADWR (reel)                   |

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

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## **ABSOLUTE MAXIMUM RATINGS**(1)

|          |                                       |   |  |          | VALUE     | UNIT |  |
|----------|---------------------------------------|---|--|----------|-----------|------|--|
| $V_{CC}$ | Supply voltag                         | je <sup>(2)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub> |  |          | -0.5 to 6 | V    |  |
| $V_{I}$  | / <sub>I</sub> Voltage at IN, OUT, EN |   |  |          |           | V    |  |
| Io       | O Output current                      |   |  |          |           | mA   |  |
|          |                                       | Human Body Model  | JEDEC Standard 22, Test Method A114-C.01 |          | ±4        |      |  |
| ESD      | Electrostatic discharge               | Field-Induced-Charged Device<br>Model                   | JEDEC Standard 22, Test Method C101      | All pins | ±1        | kV   |  |
|          |                                       | Machine Model   | ANSI/ESDS5.2-1996                        |          | ±200      | V    |  |
| TJ       | J Maximum junction temperature        |   |  |          |           | °C   |  |

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### RECOMMENDED OPERATING CONDITIONS

|                   |   | MIN  | TYP                 | MAX      | UNIT |
|-------------------|---|------|---------------------|----------|------|
| $V_{CC}$          | Supply voltage <sup>(1)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub>                         | 3.15 |                     | 5.5      | ٧    |
| I <sub>OH</sub>   | High-level output current   | -4   |                     |          | mA   |
| $I_{OL}$          | Low-level output current  |      |                     | 4        | mA   |
| t <sub>ui</sub>   | Input pulse width   | 1    |                     |          | μs   |
| 1/t <sub>ui</sub> | Signaling rate  | 0    | 1500 <sup>(2)</sup> | 1000     | kbps |
| $V_{IH}$          | High-level input voltage (IN) (EN on all devices)   | 2    |                     | $V_{CC}$ | V    |
| $V_{IL}$          | Low-level input voltage (IN) (EN on all devices)  | 0    |                     | 0.8      | V    |
| $T_{J}$           | Junction temperature  |      |                     | 150      | °C   |
| Н                 | External magnetic field-strength immunity per IEC 61000-4-8 and IEC 61000-4-9 certification |      |                     | 1000     | A/m  |

For the 5V operation,  $V_{\text{CC1}}$  or  $V_{\text{CC2}}$  is specified from 4.5V to 5.5V. For the 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V. Typical signaling rate under ideal conditions at 25°C.

All voltage values are with respect to network ground terminal and are peak voltage values.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> and V<sub>CC2</sub> at 5V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

|                  | PARAMETER                |             | TEST CONDITIONS  | MIN                   | TYP | MAX | UNIT  |
|------------------|--------------------------|-------------|--|-----------------------|-----|-----|-------|
| SUPPLY           | CURRENT                  |             |  |                       |     |     |       |
|                  | 10070004                 | Quiescent   | V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load, |                       | 1   | 3   | A     |
|                  | ISO7230A                 | 1 Mbps      | EN <sub>2</sub> at 3V  |                       | 1   | 3   | mA    |
| I <sub>CC1</sub> | 1007004 A                | Quiescent   | V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load, |                       | 6.5 | 11  | A     |
|                  | ISO7231A                 | 1 Mbps      | EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V                   |                       | 6.5 | 11  | mA    |
|                  | ISO7230A                 | Quiescent   | V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load, |                       | 15  | 22  | A     |
| loca             | 1507230A                 | 1 Mbps      | EN <sub>2</sub> at 3V  |                       | 16  | 22  | mA    |
| I <sub>CC2</sub> | ISO7231A                 | Quiescent   | V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load, |                       | 13  | 20  | A     |
|                  | 1507231A                 | 1 Mbps      | EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V                   |                       | 13  | 20  | mA    |
| ELECTR           | RICAL CHARACTERISTIC     | s           |  |                       |     |     |       |
| I <sub>OFF</sub> | Sleep mode output curr   | ent         | EN at 0V, Single channel                                       |                       | 0   |     | μΑ    |
| \/               | High-level output voltag | 10          | I <sub>OH</sub> = -4mA, See Figure 1                           | V <sub>CC</sub> – 0.8 |     |     | V     |
| V <sub>OH</sub>  | nigh-level output voltag | je          | $I_{OH} = -20\mu A$ , See Figure 1                             | V <sub>CC</sub> – 0.1 |     |     |       |
| \/               | Low-level output voltage | •           | I <sub>OL</sub> = 4mA, See Figure 1                            |                       |     | 0.4 | V     |
| V <sub>OL</sub>  | Low-level output voltage | E           | I <sub>OL</sub> = 20μA, See Figure 1                           |                       |     | 0.1 | v     |
| $V_{I(HYS)}$     | Input voltage hysteresis | 3           |  |                       | 150 |     | mV    |
| I <sub>IH</sub>  | High-level input current |             | INI from 0\/ to \/   |                       |     | 10  |       |
| I <sub>IL</sub>  | Low-level input current  |             | IN from 0V to V <sub>CC</sub>                                  | -10                   |     |     | μA    |
| C <sub>I</sub>   | Input capacitance to gro | ound        | IN at $V_{CC}$ , $V_I = 0.4 \sin (4E6\pi t)$                   |                       | 2   |     | pF    |
| CMTI             | Common-mode transier     | nt immunity | V <sub>I</sub> = V <sub>CC</sub> or 0V, See Figure 4           | 25                    | 50  |     | kV/µs |

For the 5V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For the 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V.

## SWITCHING CHARACTERISTICS: $V_{CC1}$ and $V_{CC2}$ at 5V OPERATION

|                                     | PARAMETER  | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|--|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay  | See Figure 4    | 40  |     | 95  |      |
| PWD                                 | Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub> | See Figure 1    |     |     | 10  | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew (2)   |                 |     | 0   | 2   | ns   |
| t <sub>r</sub>                      | Output signal rise time  | See Figure 4    |     | 2   |     |      |
| t <sub>f</sub>                      | Output signal fall time  | See Figure 1    |     | 2   |     | ns   |
| t <sub>PHZ</sub>                    | Propagation delay, high-level-to-high-impedance output                     |                 |     | 15  | 20  |      |
| t <sub>PZH</sub>                    | Propagation delay, high-impedance-to-high-level output                     | See Figure 2    |     | 15  | 20  |      |
| $t_{PLZ}$                           | Propagation delay, low-level-to-high-impedance output                      | See Figure 2    |     | 15  | 20  | ns   |
| t <sub>PZL</sub>                    | Propagation delay, high-impedance-to-low-level output                      |                 |     | 15  | 20  |      |
| t <sub>fs</sub>                     | Failsafe output delay time from input power loss                           | See Figure 3    |     | 12  |     | μs   |

Also referred to as pulse skew.

t<sub>sk(o)</sub> is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> at 5V, V<sub>CC2</sub> at 3.3V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

|                     | PARAMET   | ER           | TEST CONDITIONS  | 5   | MIN                   | TYP | MAX | UNIT  |
|---------------------|---|--------------|--|---|-----------------------|-----|-----|-------|
| SUPPLY              | CURRENT   |              | ,  |   | ı.                    |     | ,   |       |
|                     | ISO7230A  | Quiescent    | V V or OV All shannels no lea                                | d EN at 21/   |                       | 1   | 3   | m Λ   |
|                     | 1507230A  | 1 Mbps       | $V_I = V_{CC}$ or 0V, All channels, no loa                   | u, EN <sub>2</sub> at 3v  |                       | 1   | 3   | mA    |
| I <sub>CC1</sub>    | ISO7231A  | Quiescent    | $V_I = V_{CC}$ or 0V, All channels, no loa                   | $\text{V}_{\text{I}} = \text{V}_{\text{CC}}$ or 0V, All channels, no load, $\text{EN}_{1}$ at 3V, $\text{EN}_{2}$ at 3V |                       | 6.5 | 11  | mA    |
|                     | 1507231A  | 1 Mbps       |  |   |                       | 6.5 | 11  | IIIA  |
|                     | ISO7230A  | Quiescent    | V - V or OV All channels no lea                              | d EN at 2\/   |                       | 9   | 15  | mA    |
|                     | 1307230A  | 1 Mbps       | $V_I = V_{CC}$ or 0V, All channels, no loa                   | u, Ein <sub>2</sub> at 3v   |                       | 9.5 | 15  | IIIA  |
| I <sub>CC2</sub>    | ISO7231A  | Quiescent    | V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no loa | d, EN <sub>1</sub> at 3V,   |                       | 8   | 12  | mA    |
|                     | 1507231A  | 1 Mbps       | EN <sub>2</sub> at 3V  |   |                       | 8   | 12  | mA    |
| ELECTR              | RICAL CHARACTI  | ERISTICS     |  |   |                       |     |     |       |
| I <sub>OFF</sub>    | Sleep mode ou   | tput current | EN at 0 V, Single channel                                    |   |                       | 0   |     | μΑ    |
|                     |   |              |  | ISO7230   | V <sub>CC</sub> - 0.4 |     |     |       |
| $V_{OH}$            | High-level outp                                       | ut voltage   | I <sub>OH</sub> = -4mA, See Figure 1 ISO7231 (5-V side)      |   | V <sub>CC</sub> - 0.8 |     |     | V     |
|                     |   |              | I <sub>OH</sub> = -20μA, See Figure 1                        |   | V <sub>CC</sub> - 0.1 |     |     |       |
| V                   | Low lovel outpu                                       | ıt voltogo   | I <sub>OL</sub> = 4mA, See Figure 1                          | I <sub>OL</sub> = 4mA, See Figure 1   |                       |     | 0.4 | V     |
| $V_{OL}$            | Low-level outpu                                       | it voltage   | $I_{OL} = 20\mu A$ , See Figure 1                            |   |                       | 0.1 | V   |       |
| V <sub>I(HYS)</sub> | Input voltage hy                                      | ysteresis    |  |   |                       | 150 |     | mV    |
| I <sub>IH</sub>     | High-level input                                      | t current    | IN from OV to V  |   |                       |     | 10  |       |
| I <sub>IL</sub>     | Low-level input current IN from 0V to V <sub>CC</sub> |              | -10  |   |                       | μA  |     |       |
| Cı                  | Input capacitan                                       | ce to ground | IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$               | IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$  |                       | 2   |     | pF    |
| CMTI                | Common-mode immunity                                  | transient    | V <sub>I</sub> = V <sub>CC</sub> or 0 V, See Figure 4        |   | 25                    | 50  |     | kV/μs |

<sup>(1)</sup> For the 5-V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For the 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15 V to 3.6 V.

# SWITCHING CHARACTERISTICS: $V_{\text{CC1}}$ at 5V, $V_{\text{CC2}}$ at 3.3V OPERATION

|                                     | PARAMETER  |             | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|--|-------------|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay, low-to-high-level output                                | ISO723xA    | Coo Figure 4    | 40  |     | 100 |      |
| PWD                                 | Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub> | 150723XA    | See Figure 1    |     |     | 11  | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew (2)   | ISO723xA    |                 |     | 0   | 2.5 | ns   |
| t <sub>r</sub>                      | Output signal rise time  |             | Con Figure 4    |     | 2   |     |      |
| t <sub>f</sub>                      | Output signal fall time  |             | See Figure 1    |     | 2   |     | ns   |
| t <sub>PHZ</sub>                    | Propagation delay, high-level-to-high-impeda                               | nce output  |                 |     | 15  | 20  |      |
| t <sub>PZH</sub>                    | Propagation delay, high-impedance-to-high-le                               | evel output | Soo Figure 2    |     | 15  | 20  |      |
| $t_{PLZ}$                           | Propagation delay, low-level-to-high-impedance output                      |             | See Figure 2    |     | 15  | 20  | ns   |
| t <sub>PZL</sub>                    | Propagation delay, high-impedance-to-low-le                                | vel output  |                 |     | 15  | 20  |      |
| t <sub>fs</sub>                     | Failsafe output delay time from input power lo                             | oss         | See Figure 3    |     | 18  |     | μs   |

<sup>(1)</sup> Also known as pulse skew

<sup>(2)</sup> t<sub>sk(0)</sub> is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> at 3.3V, V<sub>CC2</sub> at 5V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

|                     | PARAMET                 | ER           | TEST CONDITIONS  | 5                         | MIN                   | TYP | MAX | UNIT  |
|---------------------|-------------------------|--------------|--|---------------------------|-----------------------|-----|-----|-------|
| SUPPLY              | CURRENT                 |              |  |                           |                       |     | 1   |       |
|                     | ISO7230A                | Quiescent    | \/ \/ or 0\/ All channels no lea                             | d FN at 2\/               |                       | 0.5 | 1   | A     |
|                     | 1507230A                | 1 Mbps       | $V_I = V_{CC}$ or 0V, All channels, no loa                   | u, Ein <sub>2</sub> at 3v |                       | 1   | 2   | mA    |
| I <sub>CC1</sub>    | ISO7231A                | Quiescent    | V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no loa | d, EN₁ at 3V,             |                       | 4.5 | 7   | A     |
|                     | 1507231A                | 1 Mbps       | EN <sub>2</sub> at 3V  |                           |                       |     | 7   | mA    |
|                     | ISO7230A                | Quiescent    | V - V or OV All channels no loo                              | d EN at 2\/               |                       | 15  | 22  | mΛ    |
|                     | 1307230A                | 1 Mbps       | $V_I = V_{CC}$ or 0V, All channels, no loa                   | u, Ein <sub>2</sub> at 3v |                       | 16  | 22  | mA    |
| I <sub>CC2</sub>    | ISO7231A                | Quiescent    | $V_I = V_{CC}$ or 0V, All channels, no loa                   | d, EN₁ at 3V,             |                       | 13  | 20  | mA    |
|                     | 1507231A                | 1 Mbps       | EN <sub>2</sub> at 3V  |                           |                       | 13  | 20  | mA    |
| ELECTR              | RICAL CHARACTI          | ERISTICS     |  |                           |                       |     |     |       |
| I <sub>OFF</sub>    | Sleep mode ou           | tput current | rrent EN at 0V, Single channel                               |                           |                       | 0   |     | μΑ    |
|                     |                         |              |  | ISO7230                   | V <sub>CC</sub> - 0.4 |     |     |       |
| $V_{OH}$            | High-level outp         | ut voltage   | $I_{OH} = -4$ mA, See Figure 1 ISO723 <sup>2</sup> (5-V side |                           | V <sub>CC</sub> - 0.8 |     |     | V     |
|                     |                         |              | I <sub>OH</sub> = –20μA, See Figure 1                        |                           | V <sub>CC</sub> - 0.1 |     |     |       |
| \ /                 | I avvilaval avvia       | st violto no | I <sub>OL</sub> = 4mA, See Figure 1                          |                           |                       |     | 0.4 | V     |
| $V_{OL}$            | Low-level outpu         | ut voltage   | I <sub>OL</sub> = 20μA, See Figure 1                         |                           |                       | 0.1 | V   |       |
| V <sub>I(HYS)</sub> | Input voltage hy        | ysteresis    |  |                           |                       | 150 |     | mV    |
| I <sub>IH</sub>     | High-level input        | t current    | IN from OV/ to V/  |                           |                       |     | 10  |       |
| I <sub>IL</sub>     | Low-level input current |              | IN from 0V to V <sub>CC</sub>                                |                           | -10                   |     |     | μA    |
| Cı                  | Input capacitan         | ce to ground | IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$               |                           |                       | 2   |     | pF    |
| CMTI                | Common-mode immunity    | transient    | V <sub>I</sub> = V <sub>CC</sub> or 0V, See Figure 4         |                           | 25                    | 50  |     | kV/μs |

<sup>(1)</sup> For 5V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V.

## SWITCHING CHARACTERISTICS: $V_{CC1}$ at 3.3V and $V_{CC2}$ at 5V OPERATION

|                                     | PARAMETER  |              | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------------------------|--|--------------|-----------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay  | 1007004      | Con Figure 4    | 40  |     | 100 |      |
| PWD                                 | Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub> | ISO723xA     | See Figure 1    |     |     | 11  | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew (2)   | ISO723xA     |                 |     | 0   | 2.5 | ns   |
| t <sub>r</sub>                      | Output signal rise time  |              | 0 5 4           |     | 2   |     |      |
| t <sub>f</sub>                      | Output signal fall time  |              | See Figure 1    |     | 2   |     | ns   |
| t <sub>PHZ</sub>                    | Propagation delay, high-level-to-high-impeda                               | ance output  |                 |     | 15  | 20  |      |
| t <sub>PZH</sub>                    | Propagation delay, high-impedance-to-high-                                 | level output | See Figure 2    |     | 15  | 20  |      |
| t <sub>PLZ</sub>                    | Propagation delay, low-level-to-high-impedance output                      |              | See Figure 2    |     | 15  | 20  | ns   |
| t <sub>PZL</sub>                    | Propagation delay, high-impedance-to-low-le                                | evel output  |                 |     | 15  | 20  |      |
| t <sub>fs</sub>                     | Failsafe output delay time from input power loss                           |              | See Figure 3    |     | 12  |     | μs   |

<sup>(1)</sup> Also known as pulse skew

 $t_{sk(o)}$  is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> and V<sub>CC2</sub> at 3.3V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

|                  | PARAMETER                   |           | TEST CONDITIONS   | MIN                   | TYP                   | MAX | UNIT  |
|------------------|-----------------------------|-----------|---|-----------------------|-----------------------|-----|-------|
| SUPPLY           | CURRENT                     |           |   |                       |                       | ,   |       |
|                  | 10070004                    | Quiescent | V <sub>I</sub> = V <sub>CC</sub> or 0 V, all channels, no load, |                       | 0.5                   | 1   | mA    |
|                  | ISO7230A                    | 1 Mbps    | EN <sub>2</sub> at 3V   |                       | 1                     | 2   | mA    |
| I <sub>CC1</sub> | ISO7231A                    | Quiescent | V <sub>I</sub> = V <sub>CC</sub> or 0V, all channels, no load,  |                       | 4.5                   | 7   | A     |
|                  | 1507231A                    | 1 Mbps    | EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V                    |                       | 4.5                   | 7   | mA    |
|                  | ISO7230A                    | Quiescent | V <sub>I</sub> = V <sub>CC</sub> or 0V, all channels, no load,  |                       | 9                     | 15  | mA    |
| lass             | 1507230A                    | 1 Mbps    | EN <sub>2</sub> at 3V   |                       | 9.5                   | 15  | mA    |
| I <sub>CC2</sub> | ISO7231A                    | Quiescent | V <sub>I</sub> = V <sub>CC</sub> or 0V, all channels, no load,  |                       | 8                     | 12  | A     |
|                  | 1507231A                    | 1 Mbps    | EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V                    |                       | 8                     | 12  | mA    |
| ELECTR           | ICAL CHARACTERISTICS        | •         |   | •                     |                       |     |       |
| I <sub>OFF</sub> | Sleep mode output current   |           | EN at 0V, single channel  |                       | 0                     |     | μΑ    |
| \/               | High-level output voltage   |           | I <sub>OH</sub> = -4mA, See Figure 1                            | V <sub>CC</sub> - 0.4 | V <sub>CC</sub> - 0.4 |     | V     |
| V <sub>OH</sub>  | nigri-level output voltage  |           | $I_{OH} = -20\mu A$ , See Figure 1                              | V <sub>CC</sub> - 0.1 | V <sub>CC</sub> - 0.1 |     |       |
|                  | Low lovel output voltage    |           | I <sub>OL</sub> = 4mA, See Figure 1                             |                       |                       | 0.4 | V     |
| $V_{OL}$         | Low-level output voltage    |           | I <sub>OL</sub> = 20μA, See Figure 1                            |                       |                       |     |       |
| $V_{I(HYS)}$     | Input voltage hysteresis    |           |   |                       | 150                   |     | mV    |
| I <sub>IH</sub>  | High-level input current    |           | INI from OV or V  |                       |                       | 10  |       |
| I <sub>IL</sub>  | Low-level input current     |           | IN from 0V or V <sub>CC</sub>                                   | -10                   |                       |     | μA    |
| Cı               | Input capacitance to ground |           | IN at V <sub>CC</sub> , V <sub>I</sub> = 0.4 sin (4E6πt)        |                       | 2                     |     | pF    |
| CMTI             | Common-mode transient imn   | nunity    | V <sub>I</sub> = V <sub>CC</sub> or 0V, See Figure 4            | 25                    | 50                    |     | kV/μs |

<sup>(1)</sup> For 5V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V.

# SWITCHING CHARACTERISTICS: $V_{CC1}$ and $V_{CC2}$ at 3.3-V OPERATION

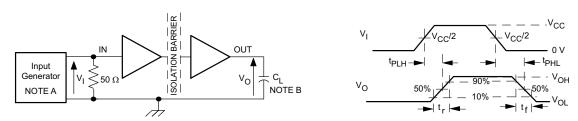
|                                     | PARAMETER  |                 | TEST CONDITIONS    | MIN | TYP | MAX | UNIT |
|-------------------------------------|--|-----------------|--------------------|-----|-----|-----|------|
| t <sub>PLH</sub> , t <sub>PHL</sub> | Propagation delay  | 1007004         | 23xA See Figure 1  |     |     | 110 |      |
| PWD                                 | Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> – t <sub>PLH</sub> | ISO723xA        | See Figure 1       |     |     | 12  | ns   |
| t <sub>sk(o)</sub>                  | Channel-to-channel output skew (2)   | ISO723xA        |                    |     | 0   | 3   | ns   |
| t <sub>r</sub>                      | Output signal rise time  |                 | See Figure 1       |     | 2   |     |      |
| t <sub>f</sub>                      | Output signal fall time  |                 |                    |     | 2   |     | ns   |
| t <sub>PHZ</sub>                    | Propagation delay, high-level-to-high-im                                   | pedance output  |                    |     | 15  | 20  |      |
| t <sub>PZH</sub>                    | Propagation delay, high-impedance-to-h                                     | gh-level output | 0 5 0              |     | 15  | 20  |      |
| t <sub>PLZ</sub>                    | Propagation delay, low-level-to-high-imp                                   | edance output   | utput See Figure 2 |     | 15  | 20  | ns   |
| t <sub>PZL</sub>                    | Propagation delay, high-impedance-to-lo                                    | w-level output  |                    |     | 15  | 20  |      |
| t <sub>fs</sub>                     | Failsafe output delay time from input por                                  | ver loss        | See Figure 3       |     | 18  |     | μs   |

<sup>(1)</sup> Also referred to as pulse skew.

<sup>(</sup>z) t<sub>sk(o)</sub> is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

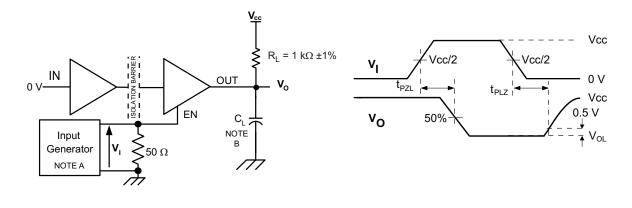


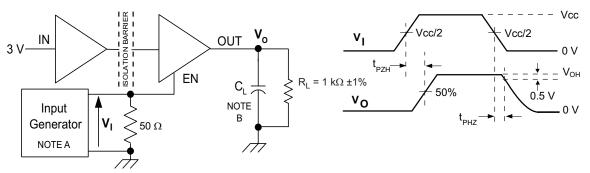
#### PARAMETER MEASUREMENT INFORMATION



- A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 50kHz, 50% duty cycle,  $t_r$  ≤ 3ns,  $t_f$  ≤ 3ns,  $Z_O$  = 50Ω.
- B.  $C_L = 15$  pF and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



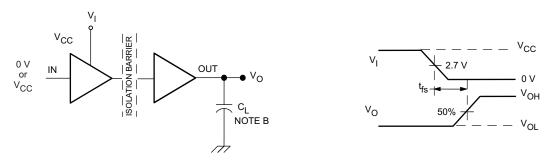


- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15$  pF and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 2. Enable/Disable Propagation Delay Time Test Circuit and Waveform

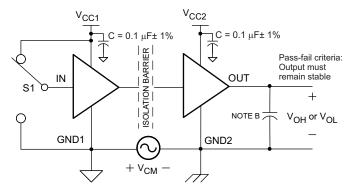
INSTRUMENTS

## **PARAMETER MEASUREMENT INFORMATION (continued)**



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15pF$  and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 3. Failsafe Delay Time Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 4. Common-Mode Transient Immunity Test Circuit and Voltage Waveform

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## **DEVICE INFORMATION**

## **PACKAGE CHARACTERISTICS**

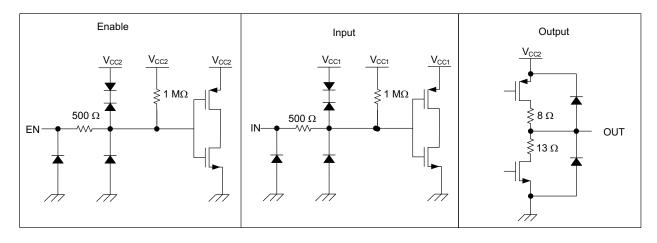
|                 | PARAMETER                                 | TEST CONDITIONS  | MIN   | TYP               | MAX | UNIT |
|-----------------|---|--|-------|-------------------|-----|------|
| L(I01)          | Minimum air gap (Clearance)               | Shortest terminal-to-terminal distance through air   | 8.34  |                   |     | mm   |
| L(102)          | Minimum external tracking (Creepage)      | Shortest terminal-to-terminal distance across the package surface  | 8.1   |                   |     | mm   |
|                 | Minimum Internal Gap (Internal Clearance) | Distance through the insulation  | 0.008 |                   |     | mm   |
| R <sub>IO</sub> | Isolation resistance                      | Input to output, $V_{IO}$ = 500V, all pins on each side of the barrier tied together creating a two-terminal device, $T_A$ < 100°C |       | >10 <sup>12</sup> |     | Ω    |
|                 |   | Input to output, $V_{IO} = 500V$ , $100^{\circ}C \le T_A \le T_A$ max  |       | >10 <sup>11</sup> |     | Ω    |
| C <sub>IO</sub> | Barrier capacitance Input to output       | $V_1 = 0.4 \sin (4E6\pi t)$  |       | 2                 |     | pF   |
| C <sub>I</sub>  | Input capacitance to ground               | $V_1 = 0.4 \sin (4E6\pi t)$  |       | 2                 |     | pF   |

## **REGULATORY INFORMATION**

| VDE                                  | CSA  | UL   |
|--------------------------------------|--|--|
| Certified according to IEC 60747-5-2 | Approved under CSA Component Acceptance Notice | Recognized under 1577<br>Component Recognition<br>Program <sup>(1)</sup> |
| File Number: 40016131                | File Number: 220991                            | File Number: E181974   |

<sup>(1)</sup> Production tested ≥ 3000 VRMS for 1 second in accordance with UL 1577.

# **DEVICE I/O SCHEMATICS**





#### THERMAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

|                      | PARAMETER                            | TEST CONDITIONS  | MIN | TYP  | MAX | UNIT |
|----------------------|--------------------------------------|--|-----|------|-----|------|
| 0                    | lunation to air                      | Low-K Thermal Resistance <sup>(1)</sup>  | 168 |      |     | °C/W |
| $\theta_{JA}$        | Junction-to-air                      | High-K Thermal Resistance  |     | 96.1 |     | C/VV |
| $\theta_{JB}$        | Junction-to-Board Thermal Resistance |  |     | 61   |     | °C/W |
| $\theta_{\text{JC}}$ | Junction-to-Case Thermal Resistance  |  |     | 48   |     | °C/W |
| $P_D$                | Device Power Dissipation             | $V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}, C_L = 15 \text{ pF},$<br>Input a 50% duty cycle square wave |     |      | 220 | mW   |

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface mount packages.

## TYPICAL CHARACTERISTIC CURVES

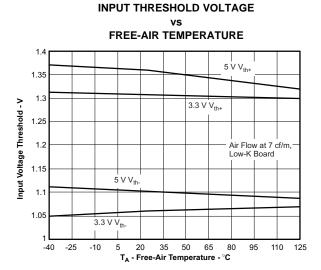
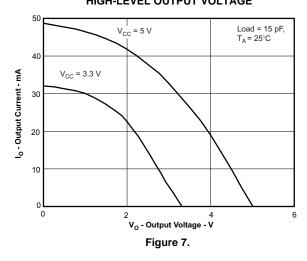


Figure 5.

## HIGH-LEVEL OUTPUT CURRENT vs HIGH-LEVEL OUTPUT VOLTAGE



V<sub>CC1</sub> FAILSAFE THRESHOLD vs FREE-AIR TEMPERATURE

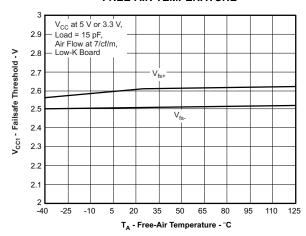


Figure 6.

# LOW-LEVEL OUTPUT CURRENT vs LOW-LEVEL OUTPUT VOLTAGE

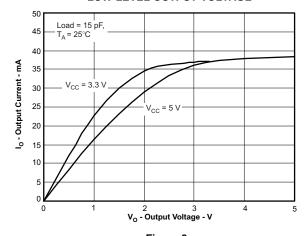


Figure 8.



#### **APPLICATION INFORMATION**

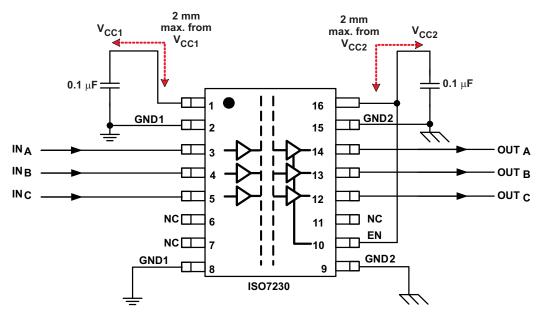


Figure 9. Typical ISO7230 Application Circuit

## LIFE EXPECTANCY vs WORKING VOLTAGE

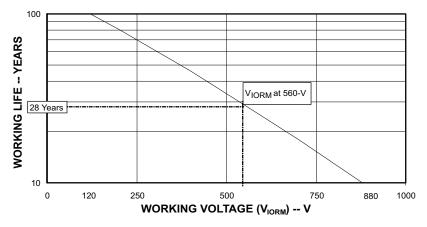


Figure 10. Time Dependant Dielectric Breakdown Testing Results

#### PRODUCT NOTIFICATION

**INSTRUMENTS** 

An ISO723xA anomaly occurs when a negative-going pulse below the specified 1µs minimum bit width is input to the device. The output locks in a logic-low condition until the next rising edge occurs after a 1µs period.

Positive noise edges in pulses of less than the minimum specified 1µs have no effect on the device, and are properly filtered.

To prevent noise from interfering with ISO723xA performance, it is recommended that an appropriately sized capacitor be placed on each input of the device

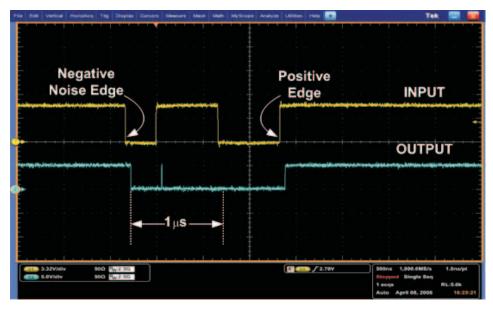


Figure 11. ISO723xA Anomaly

TEXAS INSTRUMENTS

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## **REVISION HISTORY**

| Changes from Original (May 2008) to Revision A                                   |  | Page |
|--|--|------|
| Added Product Notification section link  |  | 1    |
| <ul> <li>Deleted text from paragraph 2 of the Description:</li> </ul>            | and turns off internal bias circuitry to conserve power" | 1    |
| Deleted Product Preview note   |  | 2    |
| Changed From: 3 To: 3.15   |  | 3    |
| Changed V <sub>CC</sub> From: 3.6 To: 3.45                                       |  | 3    |
| <ul> <li>Changed I<sub>CC1</sub> and I<sub>CC2</sub> values From: TBD</li> </ul> |  | 4    |
| <ul> <li>Changed V<sub>CC</sub> – 0.4 To: V<sub>CC</sub> – 0.8</li> </ul>        |  | 4    |
| Changed Typical value from 1 To: 2   |  | 4    |
| <ul> <li>Changed Propagation delay max From: 80 To: 95</li> </ul>                | 5  | 4    |
| <ul> <li>Changed I<sub>CC1</sub> and I<sub>CC2</sub> values From: TBD</li> </ul> |  | 5    |
| Changed Typical value from 1 To: 2   |  | 5    |
| <ul> <li>Changed Propagation delay max From: 80 To: 10</li> </ul>                | 00   | 5    |
| <ul> <li>Changed I<sub>CC1</sub> and I<sub>CC2</sub> values From: TBD</li> </ul> |  | 6    |
| Changed Typical value from 1 To: 2   |  | 6    |
| <ul> <li>Changed Propagation delay max From: 80 To: 10</li> </ul>                | 00   | 6    |
| <ul> <li>Changed I<sub>CC1</sub> and I<sub>CC2</sub> values From: TBD</li> </ul> |  | 7    |
| Changed  |  | 7    |
| Changed Typical value from 1 To: 2   |  | 7    |
| <ul> <li>Changed Propagation delay max From: 85 To: 12</li> </ul>                | 10   | 7    |
| <ul> <li>Changed L(101) Minimum air gap (Clearance) - r</li> </ul>               | minimum value from: 7.7mm to: 8.34mm                     | 10   |
| Changed Typical value from 1 To: 2   |  | 10   |
| Changed Typical value from 1 To: 2   |  | 10   |
| <ul> <li>Changed the REGULATORY INFORMATION Ta</li> </ul>                        | ble  | 10   |
| Changed Figure 11  |  | 13   |
| Changes from Devision A / June 2009) to Devision                                 | n D  | Dogo |
| Changes from Revision A (June 2008) to Revision                                  |  | Page |
| Changed V <sub>CC</sub> From: 3.45 To: 3.6                                       |  | 3    |
| Changes from Revision B (July 2008) to Revision                                  | ı C  | Page |
| <ul> <li>Changed "1ns" to "2ns". added "(5v-Operation)".</li> </ul>              |  | 1    |
|  |  |      |
| -  | os"  |      |
|  | Voltage of the ROC Table                                 |      |
|  | Totage of the New Yabis.                                 |      |
|  |  |      |
| •  |  |      |
| _  |  |      |
|  |  |      |
|  |  |      |





11-May-2011

#### **PACKAGING INFORMATION**

| Orderable Device | Status <sup>(1)</sup> | Package Type | Package<br>Drawing | Pins | Package Qty | Eco Plan <sup>(2)</sup>    | Lead/<br>Ball Finish | MSL Peak Temp <sup>(3)</sup> | Samples<br>(Requires Login) |
|------------------|-----------------------|--------------|--------------------|------|-------------|----------------------------|----------------------|------------------------------|-----------------------------|
| ISO7230ADW       | NRND                  | SOIC         | DW                 | 16   | 40          | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7230ADWG4     | NRND                  | SOIC         | DW                 | 16   | 40          | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7230ADWR      | NRND                  | SOIC         | DW                 | 16   | 2000        | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7230ADWRG4    | NRND                  | SOIC         | DW                 | 16   | 2000        | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7231ADW       | NRND                  | SOIC         | DW                 | 16   | 40          | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7231ADWG4     | NRND                  | SOIC         | DW                 | 16   | 40          | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7231ADWR      | NRND                  | SOIC         | DW                 | 16   | 2000        | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |
| ISO7231ADWRG4    | NRND                  | SOIC         | DW                 | 16   | 2000        | Green (RoHS<br>& no Sb/Br) | CU NIPDAU            | Level-3-260C-168 HR          |                             |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



## **PACKAGE OPTION ADDENDUM**

11-May-2011

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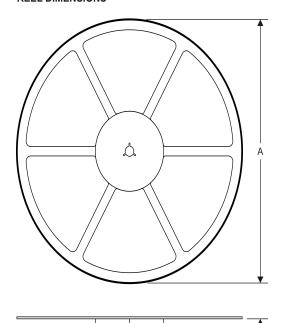
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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION

#### **REEL DIMENSIONS**



#### **TAPE DIMENSIONS**



| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

#### TAPE AND REEL INFORMATION

## \*All dimensions are nominal

| Device      | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|-------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| ISO7230ADWR | SOIC            | DW                 | 16 | 2000 | 330.0                    | 16.4                     | 10.75      | 10.7       | 2.7        | 12.0       | 16.0      | Q1               |
| ISO7231ADWR | SOIC            | DW                 | 16 | 2000 | 330.0                    | 16.4                     | 10.75      | 10.7       | 2.7        | 12.0       | 16.0      | Q1               |

# **PACKAGE MATERIALS INFORMATION**

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#### \*All dimensions are nominal

| Device      | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ISO7230ADWR | SOIC         | DW              | 16   | 2000 | 367.0       | 367.0      | 38.0        |
| ISO7231ADWR | SOIC         | DW              | 16   | 2000 | 367.0       | 367.0      | 38.0        |

DW (R-PDSO-G16)

## PLASTIC SMALL OUTLINE



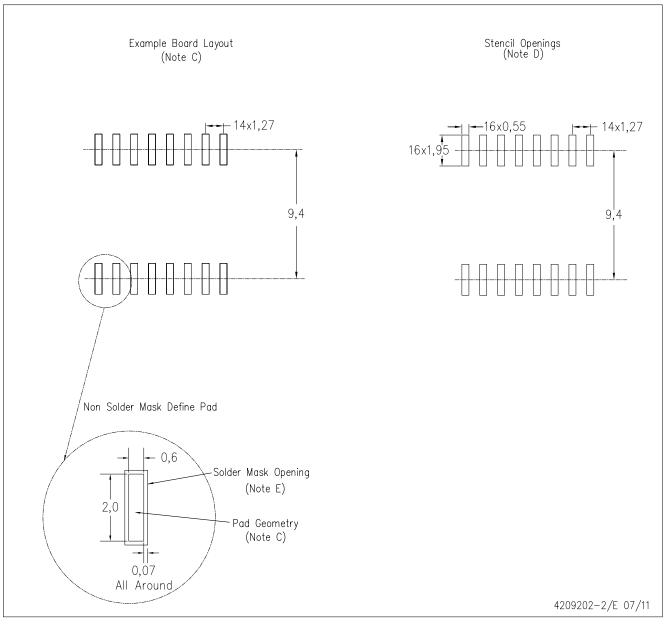
NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AA.



DW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC—7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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